

Search Notes

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Examiner

Andrew Lee

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	392, 400	3/1/2006	AL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor and Interference search	3/1/2006	AL